

**REMARKS**

Claims 1-20 are currently pending. By this Amendment, claims 1, 5, 8, 11, 15 and 18 have been amended for clarification of the claimed invention, without acquiescence in cited basis for rejection or prejudice to pursue in a related application. The support for these amendments can be found at least in paragraph [0033], Figs. 2-5 and the claims of the originally filed specification. No new matter has been added.

**Claim Rejections Under 35 U.S.C. §101**

Claims 1-20 were rejected under 35 U.S.C. §101, because the disclosed invention is allegedly inoperative and therefore lacks utility. Applicant respectfully disagrees. The claims have been amended to clarify the invention. Thus, this rejection is now moot.

For at least the foregoing reasons, Applicant respectfully requests that the § 101 rejection for claims 1 and 11, and their respective dependent claims, be withdrawn.

**Claim Rejections Under 35 U.S.C. §103**

Claims 1-9 and 11-19 are rejected under 35 U.S.C. §103(a) as being allegedly unpatentable over Masatake (JP 2003-202362) in view of Jaramillo et al. (10 Tips for Successful Scan Design: Part two, February 17, 2000, ednmag.com, pp. 77-90). Applicant respectfully traverses.

Independent claim 1 recites the following limitations:

scanning a first test data from an input pin into a first scan chain during a first state of a clock cycle to test the integrated circuit;

scanning a second test data from the input pin into a second scan chain during a second state of the clock cycle to test the integrated circuit; and

associating a lockup register with a beginning circuit element of the first or second scan chains based on a clock waveform; wherein a clock signal of the clock cycle is input to the first scan chain and the second scan chain during testing. (Emphasis added).

Applicant respectfully submits that Masatake does not disclose or suggest at least the feature of “associating a lockup register with a beginning circuit element of the first or second scan chains based on a clock waveform” (emphasis added). Specifically, Masatake disclose only a selector 3 associated with the beginning of a scan chain 12. As can be seen by Drawing 1 of Masatake, the

selector 3 associated with scan chain 11 merely selects either a positive clock or a negative clock. The claimed invention explicitly recites associating a lockup register with a beginning circuit element of the first or second scan chains. Thus, the selector of Masatake is not the same as a lockup register as claimed. Therefore, Masatake does not disclose or suggest at least “associating a lockup register with a beginning circuit element of the first or second scan chains based on a clock waveform.”

Jaramillo discloses a scan chain with mixing flip-flops (Fig. 3). Fig. 3 of Jaramillo also discloses a lockup latch. Specifically, Jaramillo discloses on page 83 first paragraph of the second column: “Whenever a falling-edge-triggered flip-flop follows a rising-edge-triggered flip-flop in a scan chain, you must insert a lockup latch between them. Jaramillo is silent with respect to associating a lockup register with a beginning element based on a clock waveform. Jaramillo inserts a lockup latch to prevent data from shifting through both flip-flops in one clock cycle and places falling-edge-triggered flip-flops at the beginning of the scan chain for each block. Jaramillo does not associate a lockup register based on a clock waveform as claimed. Therefore, Jaramillo also does not disclose or suggest at least “associating a lockup register with a beginning circuit element of the first or second scan chains based on a clock waveform.”

For at least these reasons, it is respectfully submitted that Masatake and Jaramillo, singly or in combination, does not teach or suggest the invention as a whole. For at least these same reasons, it is respectfully submitted that claims 1 and 11, as amended, are not obvious, and the rejection should be withdrawn.

Since the remaining claims respectively depend from these independent claims, these dependent claims are considered allowable over this reference for at least the same reasons as discussed above.

Claims 7, 10, 17 and 20 were rejected under 35 U.S.C. §103(a) as unpatentable over Masatake in view of Jaramillo et al. and Morton (US 2004/0078741).

However, Applicant respectfully traverses these rejections under 35 U.S.C. §103(a) for at least the reasons as set forth above because Morton was also not cited and fails to disclose or suggest

at least the feature of “associating a lockup register with a beginning circuit element of the first or second scan chains based on a clock waveform”.

Since claims 7, 10, 17 and 20 respectively depend from independent claims 1 and 11, these dependent claims are considered allowable over the cited references for at least the same reasons as discussed above and/or for at least their dependence on the independent claims.

**CONCLUSION**

Based on the foregoing, all claims are believed allowable, and an allowance of the claims is respectfully requested. If the Examiner has any questions or comments, the Examiner is respectfully requested to contact the undersigned at the number listed below.

To the extent that any arguments and disclaimers were presented to distinguish prior art, or for other reasons substantially related to patentability, during the prosecution of any and all parent and related application(s)/patent(s), Applicant(s) hereby explicitly retracts and rescinds any and all such arguments and disclaimers, and respectfully requests that the Examiner re-visit the prior art that such arguments and disclaimers were made to avoid.

The Commissioner is authorized to charge Vista IP Law Group LLP Account No. 50-1105 for any fees required that are not covered, in whole or in part, and to credit any overpayments to said Deposit Account No. 50-1105.

Respectfully submitted,

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